

High Temperature Silicon Carbide Power Schottky Diode

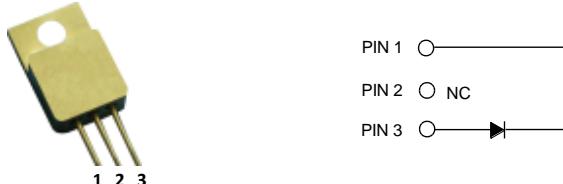
V_{RRM}	=	650 V
I_F	=	2.5 A
Q_C	=	7 nC

Features

- 650 V Schottky rectifier
- 250 °C maximum operating temperature
- Electrically isolated base-plate
- Zero reverse recovery charge
- Superior surge current capability
- Positive temperature coefficient of V_F
- Temperature independent switching behavior
- Lowest figure of merit Q_C/I_F
- Available screened to Mil-PRF-19500

Package

- RoHS Compliant



TO – 257 (Isolated Base-plate Hermetic Package)

Advantages

- High temperature operation
- Improved circuit efficiency (Lower overall cost)
- Low switching losses
- Ease of paralleling devices without thermal runaway
- Smaller heat sink requirements
- Industry's lowest reverse recovery charge
- Industry's lowest device capacitance
- Ideal for output switching of power supplies
- Best in class reverse leakage current at operating temperature

Applications

- Down Hole Oil Drilling
- Geothermal Instrumentation
- Solenoid Actuators
- General Purpose High-Temperature Switching
- Amplifiers
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)

Maximum Ratings at T_j = 250 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
Repetitive peak reverse voltage	V _{RRM}		650	V
Continuous forward current	I _F	T _C = 25 °C	2.5	A
Continuous forward current	I _F	T _C ≤ 225 °C	0.75	A
RMS forward current	I _{F(RMS)}	T _C ≤ 225 °C	1.3	A
Surge non-repetitive forward current, Half Sine Wave	I _{F,SM}	T _C = 25 °C, t _p = 10 ms	10	A
Non-repetitive peak forward current	I _{F,max}	T _C = 25 °C, t _p = 10 μs	65	A
I ² t value	∫I ² dt	T _C = 25 °C, t _p = 10 ms	0.5	A ² S
Power dissipation	P _{tot}	T _C = 25 °C	24	W
Operating and storage temperature	T _j , T _{stg}		-55 to 250	°C

Electrical Characteristics at T_j = 250 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Diode forward voltage	V _F	I _F = 0.75 A, T _j = 25 °C	1.4	2.3		V
		I _F = 0.75 A, T _j = 250 °C	2.3			
Reverse current	I _R	V _R = 650 V, T _j = 25 °C	1	5	50	μA
		V _R = 650 V, T _j = 250 °C	5			
Total capacitive charge	Q _C	I _F ≤ I _{F,MAX}	7			nC
Switching time	t _s	dI _F /dt = 200 A/μs T _j = 210 °C	V _R = 400 V	< 17		ns
			V _R = 400 V			
Total capacitance	C	V _R = 1 V, f = 1 MHz, T _j = 25 °C V _R = 400 V, f = 1 MHz, T _j = 25 °C V _R = 650 V, f = 1 MHz, T _j = 25 °C	76	12		pF
			12			
			12			

Thermal Characteristics

Thermal resistance, junction - case	R _{thJC}	9.52	°C/W
-------------------------------------	-------------------	------	------

Mechanical Properties

Mounting torque	M	0.6	Nm
-----------------	---	-----	----

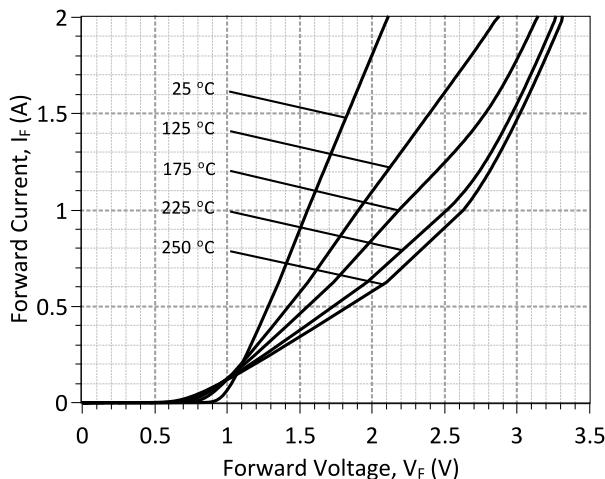


Figure 1: Typical Forward Characteristics

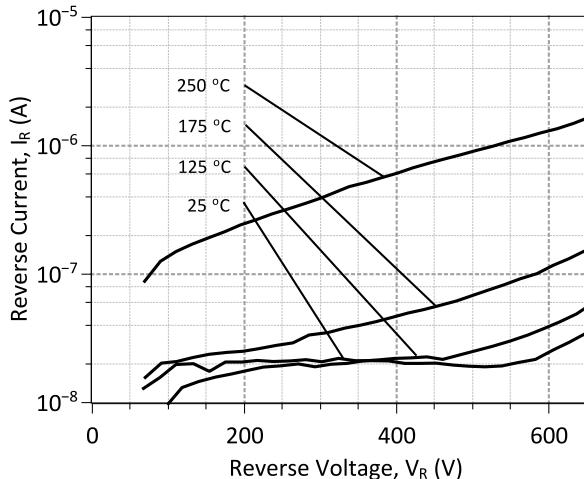


Figure 2: Typical Reverse Characteristics

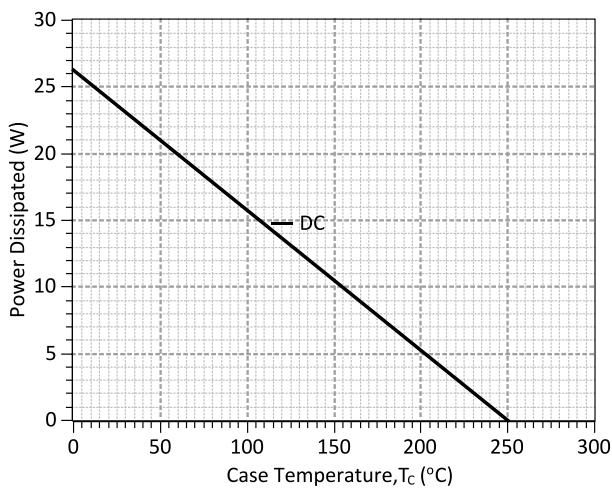


Figure 3: Power Derating Curve

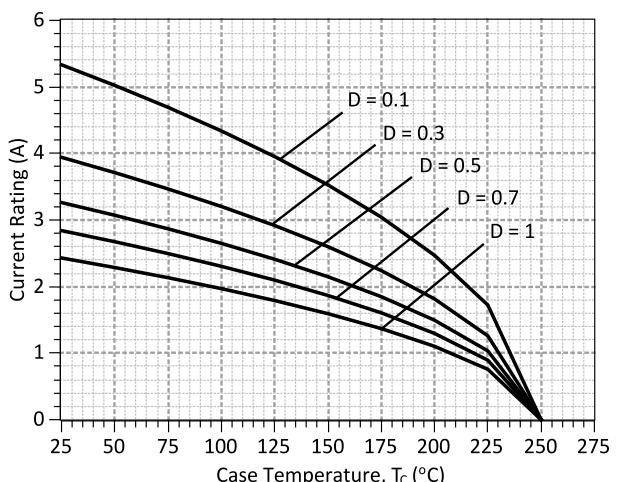


Figure 4: Current Derating Curves ($D = t_p/T$, $t_p = 400 \mu s$)
 (Considering worst case Z_{th} conditions)

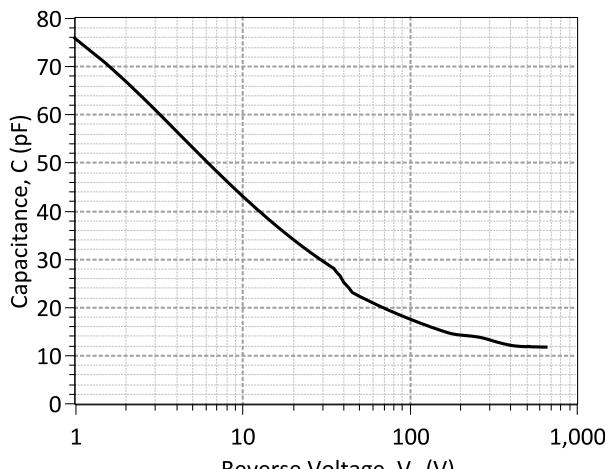


Figure 5: Typical Junction Capacitance vs Reverse Voltage Characteristics

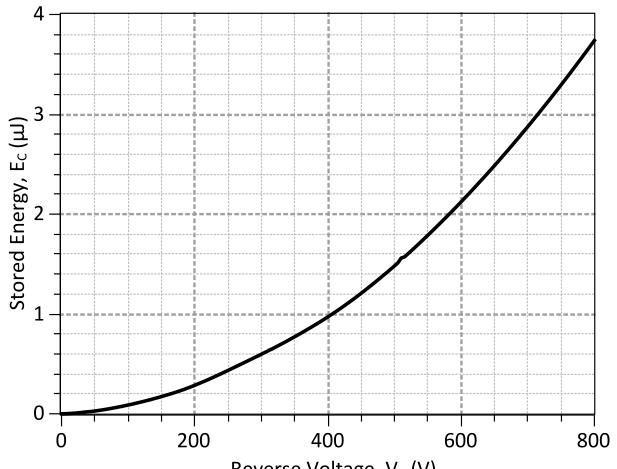


Figure 6: Typical Switching Energy vs Reverse Voltage Characteristics

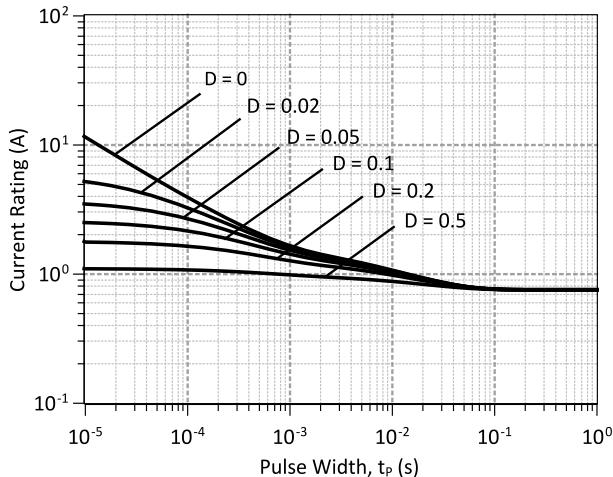


Figure 7: Current vs Pulse Duration Curves at $T_c = 225\text{ }^\circ\text{C}$

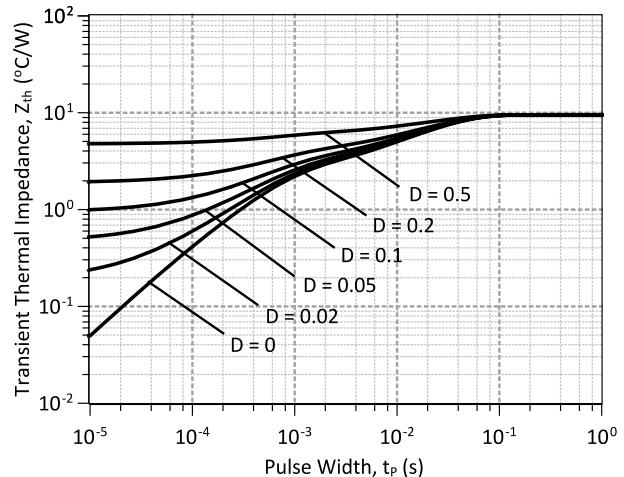
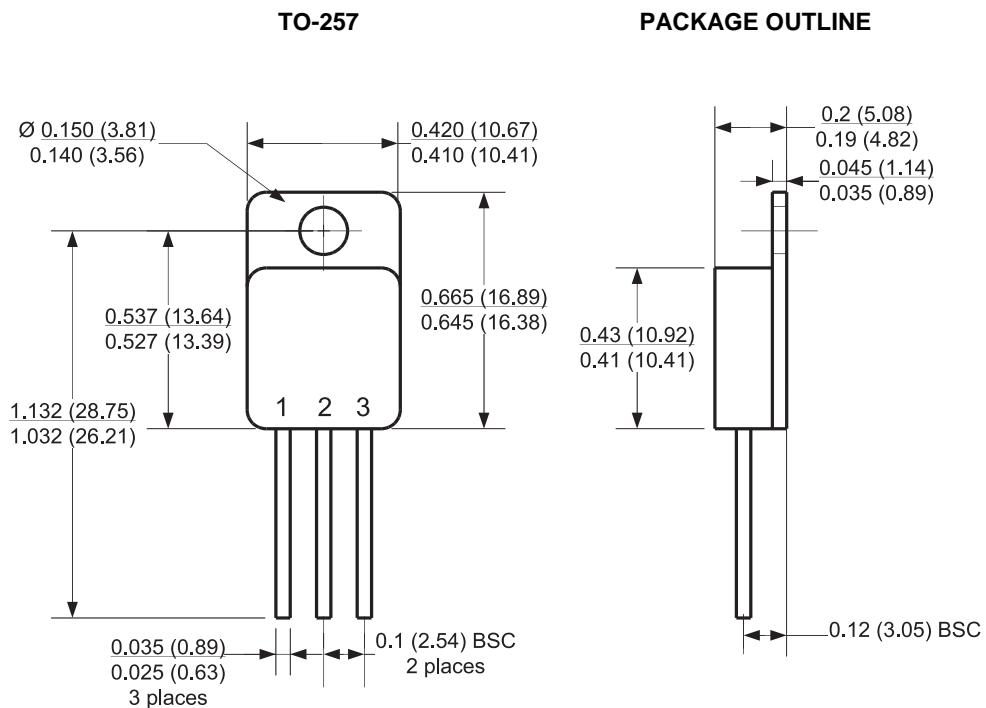


Figure 8: Transient Thermal Impedance

Package Dimensions:



NOTE

1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

Revision History			
Date	Revision	Comments	Supersedes
2014/08/26	1	Updated Electrical Characteristics	
2012/04/24	0	Initial release	

Published by

GeneSiC Semiconductor, Inc.
43670 Trade Center Place Suite 155
Dulles, VA 20166

GeneSiC Semiconductor, Inc. reserves right to make changes to the product specifications and data in this document without notice.

GeneSiC disclaims all and any warranty and liability arising out of use or application of any product. No license, express or implied to any intellectual property rights is granted by this document.

Unless otherwise expressly indicated, GeneSiC products are not designed, tested or authorized for use in life-saving, medical, aircraft navigation, communication, air traffic control and weapons systems, nor in applications where their failure may result in death, personal injury and/or property damage.

SPICE Model Parameters

This is a secure document. Copy this code from the SPICE model PDF file on our website into a SPICE software program for simulation of the 1N8030-GA.

```
* MODEL OF GeneSiC Semiconductor Inc.  
*  
* $Revision: 1.0      $  
* $Date: 05-SEP-2013 $  
  
* GeneSiC Semiconductor Inc.  
* 43670 Trade Center Place Ste. 155  
* Dulles, VA 20166  
  
* COPYRIGHT (C) 2013 GeneSiC Semiconductor Inc.  
* ALL RIGHTS RESERVED  
  
* These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY  
* OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED  
* TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A  
* PARTICULAR PURPOSE."  
* Models accurate up to 2 times rated drain current.  
  
* Start of 1N8030-GA SPICE Model  
  
.SUBCKT 1N8030 ANODE KATHODE  
D1 ANODE KATHODE 1N8030_25C; Call the Schottky Diode Model  
D2 ANODE KATHODE 1N8030_PIN; Call the PiN Diode Model  
.MODEL 1N8030_25C D  
+ IS      3.57E-18      RS      0.49751  
+ TRS1    0.0057      TRS2    2.40E-05  
+ N       1            IKF     322  
+ EG      1.2          XTI     3  
+ CJO     9.12E-11     VJ      0.371817384  
+ M       1.527759838   FC      0.5  
+ TT      1.00E-10     BV      650  
+ IBV     1.00E-03     VPK     650  
+ IAVE    1            TYPE    SiC_Schottky  
+ MFG     GeneSiC_Semiconductor  
.MODEL 1N8030_PIN D  
+ IS      5.73E-11      RS      0.72994  
+ N       5            IKF     800  
+ EG      3.23         XTI     -14  
+ FC      0.5          TT      0  
+ BV      650          IBV     1.00E-03  
+ VPK     650          IAVE    1  
+ TYPE    SiC_Pin  
.ENDS  
  
* End of 1N8030-GA SPICE Model
```